

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

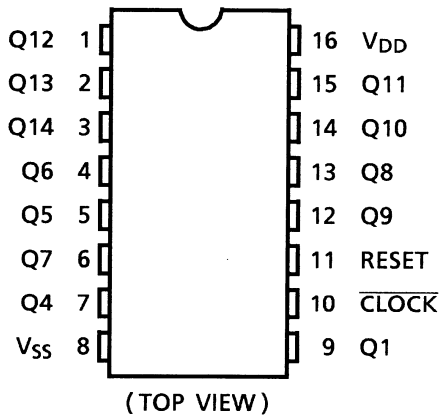
TC4020BP, TC4020BF, TC4020BFN

TC4020B 14 Stage Ripple-Carry Binary Counter/Dividers

TC4020B is 14 stage ripple carry binary counter having asynchronous clear function. The counter advances its counting stage by falling edge of $\overline{\text{CLOCK}}$ input. When $\overline{\text{RESET}}$ input is placed "H", all the circuits are reset regardless of $\overline{\text{CLOCK}}$ input making all the outputs (Q1, Q4~Q14) to be "L".

This is most suitable for frequency dividers, control circuits and timing circuits.

Pin Assignment



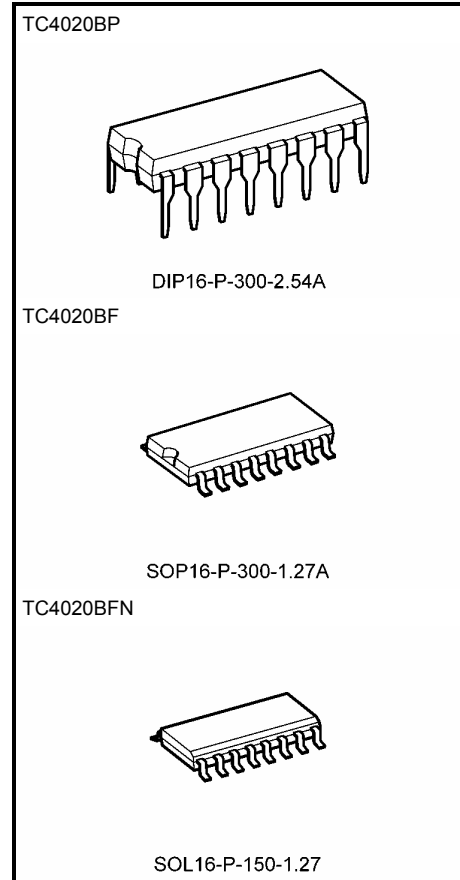
Truth Table

$\overline{\text{CLOCK}} \Delta$	RESET	Output State
*	H	All Outputs = "L"
	L	No Change
	L	Advance to Next State

Δ : Level change

*: Don't care

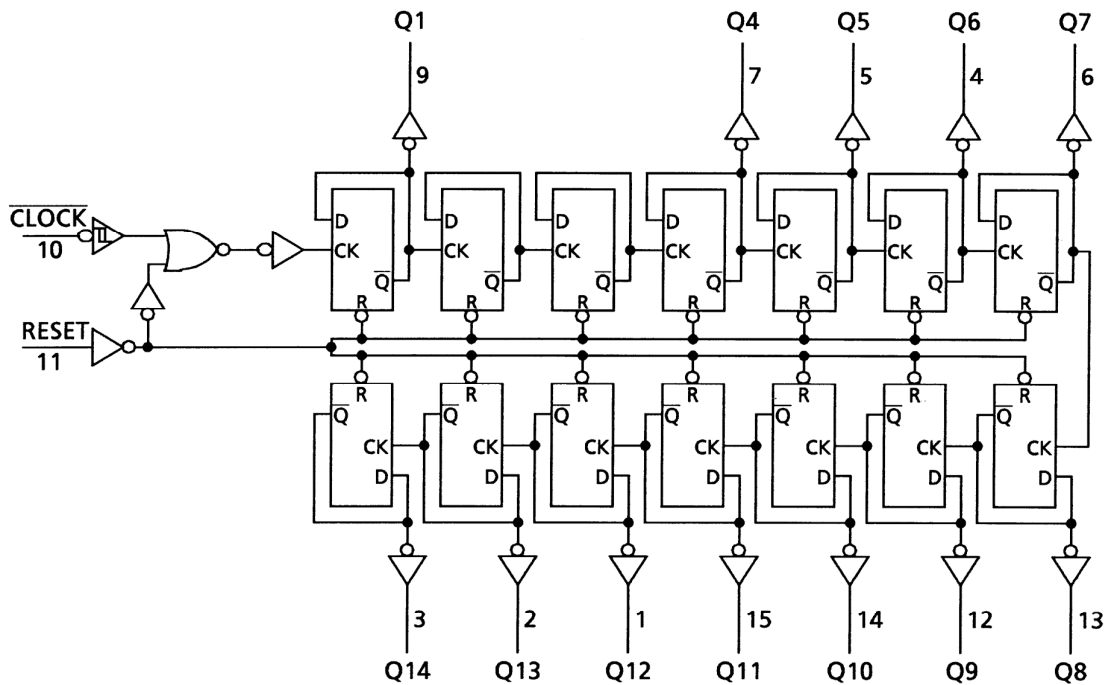
Note: xxxFN (JEDEC SOP) is not available in Japan.



Weight

DIP16-P-300-2.54A	: 1.00 g (typ.)
SOP16-P-300-1.27A	: 0.18 g (typ.)
SOL16-P-150-1.27	: 0.13 g (typ.)

Logic Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
DC supply voltage	V_{DD}	$V_{SS} - 0.5 \sim V_{SS} + 20$	V
Input voltage	V_{IN}	$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
Output voltage	V_{OUT}	$V_{SS} - 0.5 \sim V_{DD} + 0.5$	V
DC input current	I_{IN}	± 10	mA
Power dissipation	P_D	300 (DIP)/180 (SOIC)	mW
Operating temperature range	T_{opr}	$-40 \sim 85$	$^{\circ}\text{C}$
Storage temperature range	T_{stg}	$-65 \sim 150$	$^{\circ}\text{C}$

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges ($V_{SS} = 0\text{ V}$) (Note)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
DC supply voltage	V_{DD}	—	3	—	18	V
Input voltage	V_{IN}	—	0	—	V_{DD}	V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{DD} or V_{SS} .

Static Electrical Characteristics (V_{SS} = 0 V)

Characteristics	Sym- bol	Test Condition	V _{DD} (V)	-40°C		25°C			85°C		Unit	
				Min	Max	Min	Typ.	Max	Min	Max		
High-level output voltage	V _{OH}	I _{OUT} < 1 μA V _{IN} = V _{SS} , V _{DD}	5	4.95	—	4.95	5.00	—	4.95	—	V	
			10	9.95	—	9.95	10.00	—	9.95	—		
			15	14.95	—	14.95	15.00	—	14.95	—		
Low-level output voltage	V _{OL}	I _{OUT} < 1 μA V _{IN} = V _{SS} , V _{DD}	5	—	0.05	—	0.00	0.05	—	0.05	V	
			10	—	0.05	—	0.00	0.05	—	0.05		
			15	—	0.05	—	0.00	0.05	—	0.05		
Output high current	I _{OH}	V _{OH} = 4.6 V	5	-0.61	—	-0.51	-1.0	—	-0.42	—	mA	
		V _{OH} = 2.5 V	5	-2.50	—	-2.10	-4.0	—	-1.70	—		
		V _{OH} = 9.5 V	10	-1.50	—	-1.30	-2.2	—	-1.10	—		
		V _{OH} = 13.5 V	15	-4.00	—	-3.40	-9.0	—	-2.80	—		
		V _{IN} = V _{SS} , V _{DD}										
Output low current	I _{OL}	V _{OL} = 0.4 V	5	0.61	—	0.51	1.2	—	0.42	—	mA	
		V _{OL} = 0.5 V	10	1.50	—	1.30	3.2	—	1.10	—		
		V _{OL} = 1.5 V	15	4.00	—	3.40	12.0	—	2.80	—		
		V _{IN} = V _{SS} , V _{DD}										
Input high voltage	V _{IH}	V _{OUT} = 0.5 V, 4.5 V	5	3.5	—	3.5	2.75	—	3.5	—	V	
		V _{OUT} = 1.0 V, 9.0 V	10	7.0	—	7.0	5.50	—	7.0	—		
		V _{OUT} = 1.5 V, 13.5 V	15	11.0	—	11.0	8.25	—	11.0	—		
		I _{OUT} < 1 μA										
Input low voltage	V _{IL}	V _{OUT} = 0.5 V, 4.5 V	5	—	1.5	—	2.25	1.5	—	1.5	V	
		V _{OUT} = 1.0 V, 9.0 V	10	—	3.0	—	4.50	3.0	—	3.0		
		V _{OUT} = 1.5 V, 13.5 V	15	—	4.0	—	6.75	4.0	—	4.0		
		I _{OUT} < 1 μA										
Input current	"H" level	I _{IH}	V _{IH} = 18 V	18	—	0.1	—	10 ⁻⁵	0.1	—	1.0	μA
	"L" level	I _{IL}	V _{IL} = 0 V	18	—	-0.1	—	-10 ⁻⁵	-0.1	—	-1.0	
Quiescent supply current	I _{DD}	V _{IN} = V _{SS} , V _{DD} (Note)	5	—	5	—	0.005	5	—	150	μA	
			10	—	10	—	0.010	10	—	300		
			15	—	20	—	0.015	20	—	600		

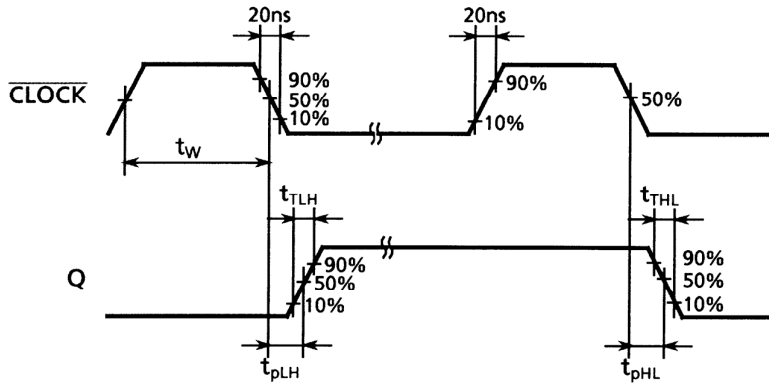
Note: All valid input combinations.

Dynamic Electrical Characteristics (Ta = 25°C, VSS = 0 V, CL = 50 pF)

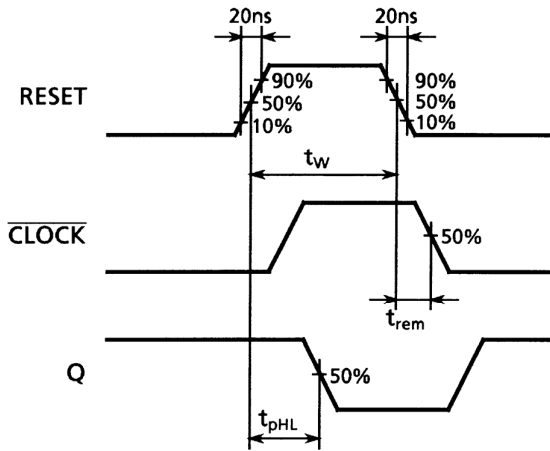
Characteristics	Symbol	Test Condition	VDD (V)	Min	Typ.	Max	Unit
Output transition time (low to high)	t _{TLH}	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Output transition time (high to low)	t _{THL}	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Propagation delay time ($\overline{\text{CLOCK}}$ -Q1)	t _{pLH}	—	5	—	160	360	ns
			10	—	80	160	
			15	—	65	130	
Propagation delay time ($\overline{\text{CLOCK}}$ -Q1)	t _{pHL}	—	5	—	160	360	ns
			10	—	80	160	
			15	—	65	130	
Propagation delay time ($\overline{\text{CLOCK}}$ -Q14)	t _{pLH}	—	5	—	1000	2000	ns
			10	—	500	1000	
			15	—	400	800	
Propagation delay time ($\overline{\text{CLOCK}}$ -Q14)	t _{pHL}	—	5	—	1000	2000	ns
			10	—	500	1000	
			15	—	400	800	
Propagation delay time (RESET-Q)	t _{pHL}	—	5	—	150	280	ns
			10	—	70	120	
			15	—	50	100	
Max clock frequency	f _{CL}	—	5	3.5	10	—	MHz
			10	8.0	20	—	
			15	12.0	25	—	
Min clock pulse width (RESET)	t _W	—	5	—	50	140	ns
			10	—	20	60	
			15	—	15	40	
Min pulse width	t _W	—	5	—	100	200	ns
			10	—	40	80	
			15	—	30	60	
Min removal time (RESET- $\overline{\text{CLOCK}}$)	t _{rem}	—	5	—	—	350	ns
			10	—	—	150	
			15	—	—	100	
Max clock input rise time Max clock input fall time	t _{rCL} t _{fCL}	—	5	No limit			μs
			10				
			15				
Input capacitance	C _{IN}	—	—	5	7.5	—	pF

Operating Supply Current Test Circuit

Waveform 1



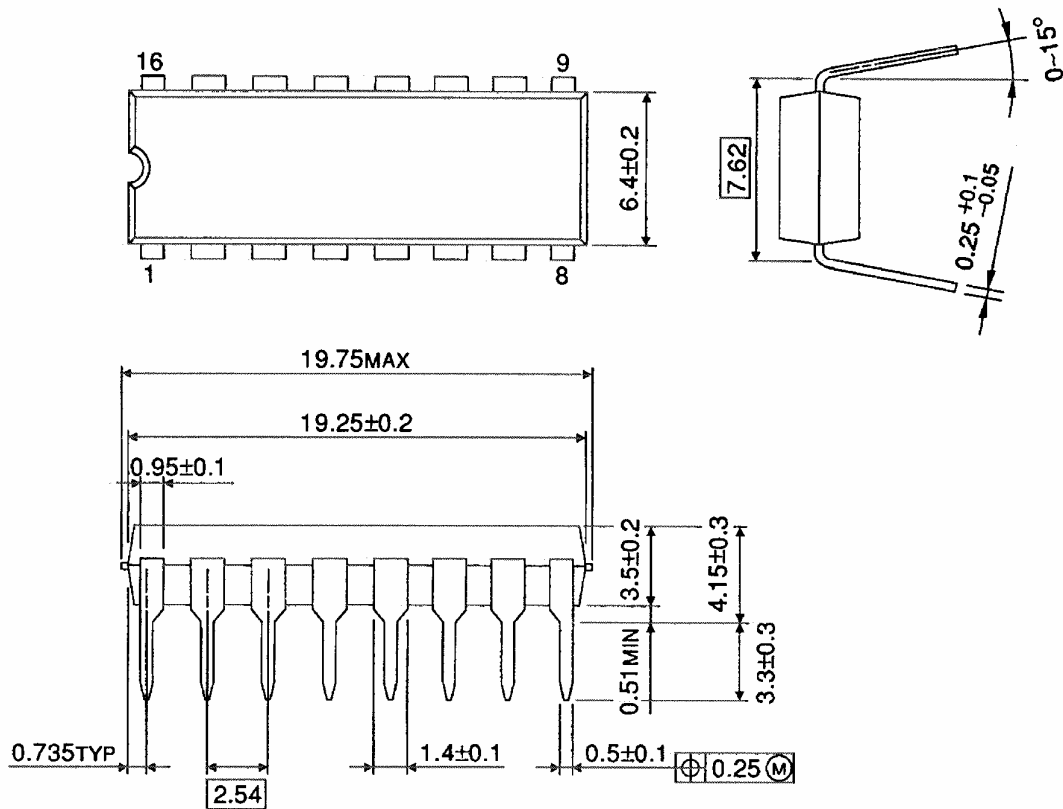
Waveform 2



Package Dimensions

DIP16-P-300-2.54A

Unit : mm

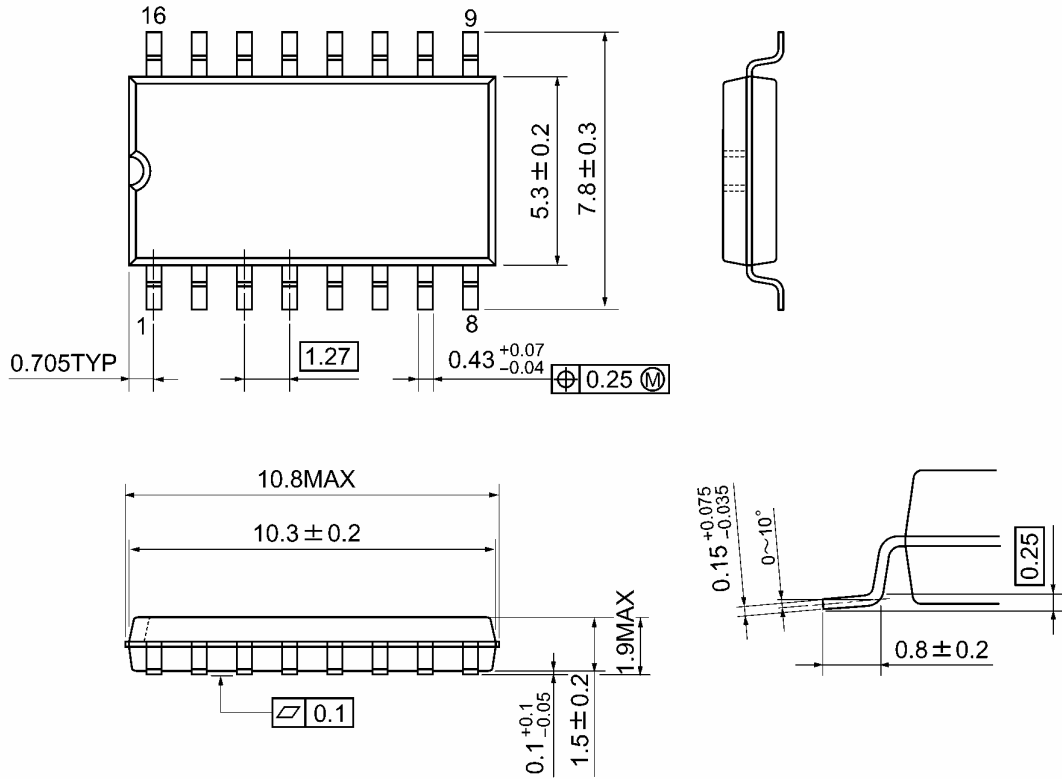


Weight: 1.00 g (typ.)

Package Dimensions

SOP16-P-300-1.27A

Unit: mm

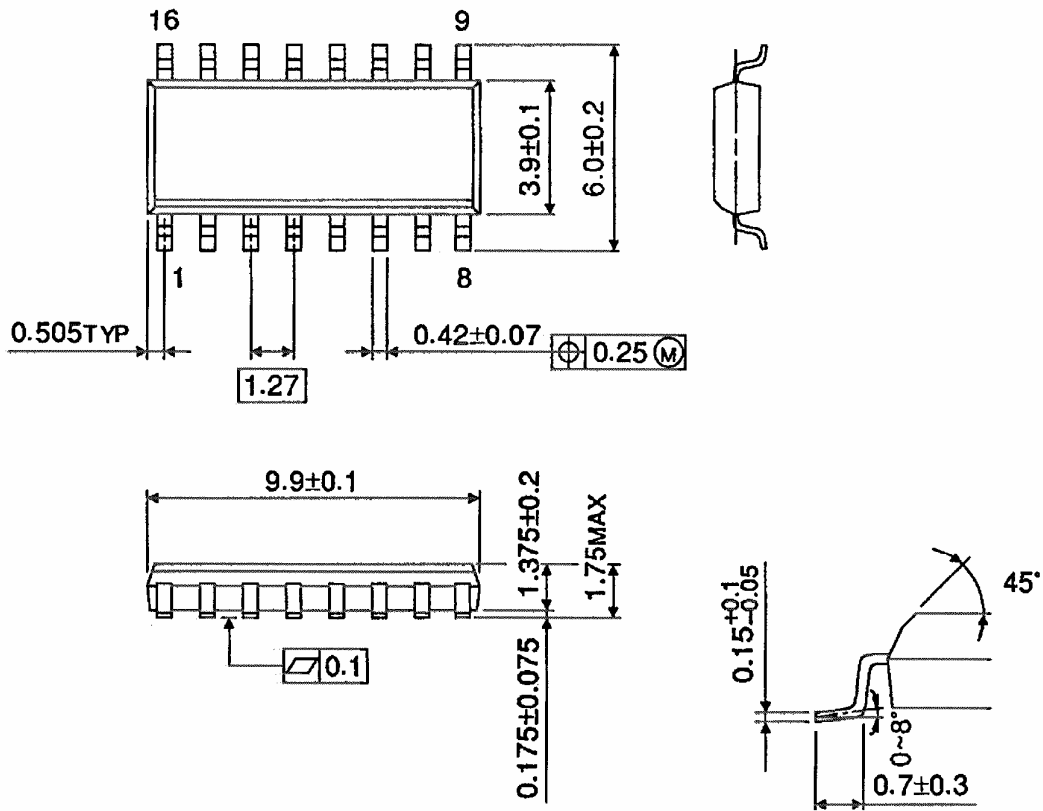


Weight: 0.18 g (typ.)

Package Dimensions (Note)

SOL16-P-150-1.27

Unit : mm



Note: This package is not available in Japan.

Weight: 0.13 g (typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

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